## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | YUEH, WEN HSIANG | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0049262	12-2001	Lehtonen, Arto	455/41
*	В	US-6,873,862 B2	03-2005	Reshefsky, Marc Alan	455/569.1
*	С	US-2003/0036360 A1	02-2003	Russell et al.	455/66
*	D	US-6,606,506 B1	08-2003	Jones, Albert C.	455/566
*	Е	US-5,771,441 A	06-1998	Altstatt, John E.	455/66.1
*	F	US-6,006,115 A	12-1999	Wingate, Richard C.	455/575.2
*	G	US-5,991,637 A	11-1999	Mack et al.	455/563
	н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	·

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.